Application/Control No. Applicant(s)/Patent Under Reexamination 10/699,343 TAKA ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 1774 Betelhem Shewareged **U.S. PATENT DOCUMENTS Document Number** Date Classification Name Country Code-Number-Kind Code MM-YYYY * US-6,492,005 B1 12-2002 Ohbayashi et al. 428/32.29 Α US-2003/0068475 A1 04-2003 Ohbayashi et al. 428/195 В С US-2004/0157009 A1 08-2004 Ohbayashi et al. 428/032.1 * 08-2000 US-6,096,469 Anderson et al. 430/119 D 05-2003 US-6,562,441 B1 Maeda et al. 428/32.34 Ε US-F US-G US-Н US-US-J US-K US-US-М **FOREIGN PATENT DOCUMENTS Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)

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